Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/747,644	DEMIR ET AL.		
Examiner	Art Unit		
Eva Yi Zheng	2611		

	SEARCHED					
Class	Subclass	Date	Examiner			
375	322	11/14/2006	E.Z			
375	316	11/14/2006	E.Z			
455	249	11/14/2006	E.Z			
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-	0					

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
		•		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST(USPAT;US- PGPUB;EPO;JPO;DERWENT;IBM- TDB)	11/14/2006	E.Z
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